CERTIFICATE OF ACCREDITATION

The ANSI National Accreditation Board

Hereby attests that

Canadian Measurement-Metrology Inc.
2433 Meadowvale Blvd.
Mississauga, Ontario, L5N 5S2 Canada

Fulfills the requirements of

ISO/IEC 17025:2017

In the fields of

CALIBRATION
and
DIMENSIONAL MEASUREMENT

This certificate is valid only when accompanied by a current scope of accreditation document.
The current scope of accreditation can be verified at www.anab.org.

Jason Stine, Vice President

Expiry Date: 17 July 2025

Certificate Number: ACT-1284

This laboratory is accredited in accordance with the recognized International Standard ISO/IEC 17025:2017.
This accreditation demonstrates technical competence for a defined scope and the operation of a laboratory quality management system (refer to joint ISO-ILAC-IAF Communiqué dated April 2017).

SCOPE OF ACCREDITATION TO ISO/IEC 17025:2017

Canadian Measurement-Metrology Inc.
2433 Meadowvale Blvd.
Mississauga, Ontario, L5N 5S2 Canada
Margot Wax
905-819-7878

CALIBRATION & DIMENSIONAL MEASUREMENT

Valid to: **July 17, 2025** Certificate Number: **ACT-1284**

CALIBRATION

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-) [2]	Reference Standard, Method, and/or Equipment
CMM X, Y, Z Linear Displacement Accuracy[1]	(25 to 2 250) mm	$(1.1 + 0.05L^2)$ µm	ASME B89.4.1B-1997/2001 using Starrett-Weber or MTI Step Bar
	(25 to 6 000) mm	$(0.01 + 0.45L + 0.04L^2)$ µm	ASME B89.4.1B-1997/2001 using Renishaw Laser Interferometer
CMM Length Measurement Error[1]	(25 to 610) mm	$(1.2 + 0.05L^2)$ µm	ISO 10360.2:2009 using Mitutoyo Step Bar
	(25 to 6 000) mm	$(0.98 + 0.01L + 0.11L^2)$ µm	ISO 10360.2:2009 using Renishaw Laser with Gage Block
CMM Scanning Probing Error (THP)[1]	Nominal Sphere Diameter: 25 mm	0.74 µm	ISO 10360-4:2000 using Precision Sphere
CMM Single-stylus Probing Error[1] (Pftu and Pstu)	Nominal Sphere Diameter: 25 mm	0.60 µm	ISO 10360-5:2010 at 6.2 using Precision Sphere
Optical/Contour Projectors X, Y Linear Accuracy[1]	X, Y: Up to 600 mm	$(1.2 + 0.02L + 0.22L^2)$ µm	ASME B89.4.18 using Glass Scale
Optical/Vision Measuring Systems X, Y, Z Linear Accuracy[1]	X, Y: Up to 610 mm	$(0.81 + 0.12L^2)$ µm	Internal Calibration Procedure using Optical Grid Plate
	Z: Up to 102 mm	$(2.4 + 0.43L^2)$ µm	Internal Calibration Procedure using Optical Step Gage

Length – Dimensional Metrology

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-) [2]	Reference Standard, Method, and/or Equipment
Articulated Arm CMM (AACMM) Volumetric Performance	Up to 1 210 mm	$(3.3 + 0.44L + 1.6L^2)$ µm	ASME B89.4.22, except Effective Diameter using Test Length Standard
Length Standard for AACMM	Up to 1 210 mm	$(2.4 + 0.52L + 1.4L^2)$ µm	Internal Calibration procedure using CMM
Articulated Arm CMM (AACMM) Volumetric Performance	Up to 3 000 mm	$(2.7 + 3.6L + 0.05L^2)$ µm	ISO 10360-12 Using KOBA length Standard
Articulated Arm CMM (AACMM) Probing Size and Form	Nominal Sphere Diameter: 25 mm	2.0 µm	ISO 10360-12:2016 at 6.2 and 6.3 using Precision Sphere
Articulated Arm CMM (AACMM) Laser Size and Form	Nominal Sphere Diameter: 25 mm	2.0 µm	ISO 10360-8:2014 at 6.2 using Precision Sphere

DIMENSIONAL MEASUREMENT

3 Dimensional

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-) [2]	Reference Standard, Method, and/or Equipment
Dimensional Measurement 3D	X = Up to 1 200 mm Y = Up to 3 000 mm Z = Up to 1 000 mm	$(4.3 + 0.70L + 2.3L^2)$ µm	Coordinate Measuring Machine and Software utilized as Reference Standard for Dimensional Measurement
	X = Up to 1 500 mm Y = Up to 2 200 mm Z = Up to 1 000 mm	$(5.3 + 0.09L + 1.0L^2)$ µm	
	X = Up to 2 000 mm Y = Up to 5 100 mm Z = Up to 1 500 mm	$(16 + 0.24L + 2.8L^2)$ µm	
	X= Up to 1 200 mm Y = Up to 2 200 mm Z = Up to 1 000 mm	$(4.8 + 0.12L + 1.1L^2)$ µm	
	X= Up to 700 mm Y = Up to 1 000 mm Z = Up to 700 mm	$(3.7 + 0.22L + 1.2L^2)$ µm	

Parameter/Equipment	Range	Expanded Uncertainty of Measurement (+/-) [2]	Reference Standard, Method, and/or Equipment
Dimensional Measurement 3D[1]	Measuring Envelopes (1.2 to 3.6) m	45 µm	Articulated Arm CMM and Software utilized as Reference Standard for Dimensional Measurement
	Absolute Distance Measurement (ADM) Range (1 to 40) m	$(18 + 0.04L + 1.3L^2)$ µm	LTD800 Leica Laser Tracker with Corner Cube Reflector and Software utilized as Reference Standard for Dimensional Measurement
	Measurement of 2 500 mm Spatial Length from Distance (1 to 10) m	$(44 + 0.54L^2)$ µm	LTD800 Leica Laser Tracker with Leica T-Probe and Software utilized as Reference Standard for Dimensional Measurement
Dimensional Measurement 3D[1, 2]	Measurement of 2 500 mm Spatial Length from Distance (1 to 80) m	$(23 + 0.02L + 1.0L^2)$ µm	AT402 Leica Laser Tracker with Corner Cube Reflector and Software utilized as Reference Standard for Dimensional Measurement
Dimensional Measurement 3D[2]	X = Up to 300 mm Y = Up to 300 mm Z = Up to 250 mm	$(3.9 + 0.07L + 8.9L^2)$ µm	Optical Vision Measuring System and Software utilized as Reference Standard for Dimensional Measurement

Calibration and Measurement Capability (CMC) is expressed in terms of the measurement parameter, measurement range, expanded uncertainty of measurement and reference standard, method, and/or equipment. The expanded uncertainty of measurement is expressed as the standard uncertainty of the measurement multiplied by a coverage factor of 2 (k=2), corresponding to a confidence level of approximately 95%.

Notes:

1. On-site calibration service is available for this parameter, since on-site conditions are typically more variable than those in the laboratory, larger measurement uncertainties are expected on-site than what is reported on the accredited scope.
2. L = Length in meter and that value is squared.
3. This scope is formatted as part of a single document including Certificate of Accreditation No. ACT-1284.

Jason Stine, Vice President